



Refractory Metal Alloys Metallurgy and Technology

By I. Machlin

Springer Jun 2012, 2012. Taschenbuch. Book Condition: Neu. 254x178x26 mm. Neuware - This publication documents Proceedings of the Symposium on Metal lurgy and Technology of Refractory Metal Alloys, held in Washington, D.C. at the Washington Hilton Hotel on April 25-26, 1968, under sponsorship of the Refractory Metals Committee, Institute of Metals Division, of the Metallurgical Society of AIME, and the National Aeronautics and Space Administration. The Symposium presented critical reviews of selected topics in refractory metal alloys, thereby contributing to an in-depth understanding of the state-of-the-art, and establishing a base line for further research, development, and application. This Symposium is fifth in a series of conferences on refractory metals, sponsored by the Metallurgical Society of AIME. Publications issuing from the conferences are valuable technical and historical source books, tracing the evolution of refractory metals from early laboratory alloying studies to their present status as useful engineering materials. Refractory metals are arbitrarily defined by melting point. A 0 melting temperature of over 3500 F was selected as the minimum for this Symposium, thus excluding chromium and vanadium, which logically could be treated with other refractory metals in Groups VA and VIA of the periodic table. The Refractory Metals Committee is planning...



Reviews

A top quality publication along with the font used was intriguing to read. I really could comprehended everything using this written e ebook. Its been designed in an remarkably straightforward way and it is only after i finished reading through this publication by which basically altered me, modify the way i believe.

-- Cathrine Larkin Sr.

Very useful to all of group of people. I actually have read through and so i am certain that i will planning to study yet again once again down the road. I am just very easily can get a satisfaction of looking at a created book.

-- Mark Bernier

See Also



Psychologisches Testverfahren

Reference Series Books LLC Nov 2011, 2011. Taschenbuch. Book Condition: Neu. 249x191x7 mm. This item is printed on demand - Print on Demand Neuware - Quelle: Wikipedia. Seiten: 100. Kapitel: Myers-Briggs-Typindikator, Keirsey Temperament Sorter, DISG, Eignungstest für das Medizinstudium, Adult Attachment Interview,...



JA] early childhood parenting: 1-4 Genuine Special (Chinese Edition)

paperback. Book Condition: New. Ship out in 2 business day, And Fast shipping, Free Tracking number will be provided after the shipment. Paperback. Pub Date :2006-01-01 Pages: 179 Publisher: the China Pictorial Our book is all new book of genuine special spot any...



Programming in D: Tutorial and Reference

Ali Cehreli, 2015. Paperback. Book Condition: New. 254 x 178 mm. Language: English . Brand New Book ***** Print on Demand *****. The main aim of this book is to teach D to readers who are new to computer programming. Although having experience...



Programming in D

Ali Cehreli Dez 2015, 2015. Buch. Book Condition: Neu. 264x182x53 mm. This item is printed on demand - Print on Demand Neuware - The main aim of this book is to teach D to readers who are new to computer programming. Although...



History of the Town of Sutton Massachusetts from 1704 to 1876

Createspace, United States, 2015. Paperback. Book Condition: New. annotated edition. 229 x 152 mm. Language: English. Brand New Book ***** Print on Demand *****. This version of the History of the Town of Sutton Massachusetts from 1704 to 1876 is a labor...



Index to the Classified Subject Catalogue of the Buffalo Library; The Whole System Being Adopted from the Classification and Subject Index of Mr. Melvil Dewey, with Some Modifications.

Rarebooksclub.com, United States, 2013. Paperback. Book Condition: New. 246 x 189 mm. Language: English . Brand New Book ***** Print on Demand *****. This historic book may have numerous typos and missing text. Purchasers can usually download a free scanned copy of the...